## Issue Classification



Application/Control No.	Applicant(s)/Patent Under Reexamination						
10576159	GUEZ ET AL.						
Examiner	Art Unit						
Sunray R Chang	2121						

ORIGINAL							INTERNATIONAL CLASSIFICATION								
CLASS SUBCLASS									С	LAIMED		NON-CLAIMED			
700 104  CROSS REFERENCE(S)			G	0	6	F	19 / 00 (2006.0)								
			G	0	2	В	6 / 26 (2006.0)								
CROSS REFERENCE(S)					G	0	2	В	6 / 42 (2006.0)						
CLASS	s	SUBCLASS (ONE SUBCLASS PER BLOCK)					0	2	В	6 / 36 (2006.0)					
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	Claims renumbered in the same order as presented by applicant							СР	A [	] T.D.	☐ R.1.47				
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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/Sunray R Chang/ Examiner.Art Unit 2121	01/05/2009	Total Claims Allowed:			
(Assistant Examiner)	(Date)				
/Albert DeCady/ Supervisory Patent Examiner, Art Unit 2121		O.G. Print Claim(s)	O.G. Print Figure		
(Primary Examiner)	(Date)	1	4		